

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 67161-140		SERIAL NO. Divisional of Appl. No. 10/077,833	
				APPLICANT Naoya WATANABE, et al.			
				FILING DATE April 13, 2004		GROUP	
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EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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						Yes	No
SN		JP 10-050958	02/20/1998				
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
SN		"Figure 9 SDRAM Functional Block Diagram", IEEE Micro, November/December 1997, pp. 38-39.					
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EXAMINER				DATE CONSIDERED			
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